

Notice of References Cited	Application/Control No. 10/554,233		Applicant(s)/Patent Under Reexamination OIKE ET AL.	
	Examiner David M. Brunsman		Art Unit 1755	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,376,634 B1	04-2002	Nishikawa et al.	528/25
*	C	US-6,797,391 B2	09-2004	Shibato et al.	428/447
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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